





### **General Description**

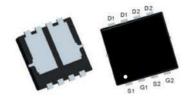
- Trench Power LV MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low R<sub>DS(ON)</sub>

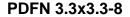
# **Applications**

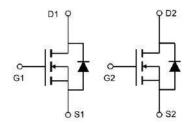
- High current load applications
- Load switching
- Hard switched and high frequency circuits
- Uninterruptible power supply

# **Product Summary**

<b>V</b> DS	40	V
$R_{DS(on),Typ}$ @ $V_{GS}=10 \text{ V}$	15	mΩ
I D	20	Α







**NMOS** 

#### **Absolute Maximum Ratings** (T<sub>A</sub>=25°C unless otherwise noted)

Parameter		Symbol	Limit	Unit
Drain-source Voltage		V <sub>DS</sub>	40	V
Gate-source Voltage		V <sub>GS</sub>	±20	V
Dunin Comment	T <sub>C</sub> =25℃	20		
Drain Current	T <sub>C</sub> =100℃	l <sub>D</sub>	16	A
Pulsed Drain Current <sup>A</sup>		I <sub>DM</sub>	80	А
Single Pulse Avalanche Energy <sup>B</sup>		E <sub>AS</sub>	70	mJ
Total Power Dissipation	T <sub>C</sub> =25℃	P <sub>D</sub>	21	W
Thermal Resistance Junction-to-Ambient		R <sub>eJA</sub>	35	°C/W
Thermal Resistance Junction-to-Case		R <sub>eJC</sub>	3.0	°C/ W
Junction and Storage Temperature Range		T <sub>J</sub> ,T <sub>STG</sub>	-55∼+150	$^{\circ}$



# ASDM40DN20E

# **40V Dual N-Channel Power MOSFET**

#### **Electrical Characteristics** (T<sub>J</sub>=25°C unless otherwise noted)

Parameter	Symbol	Conditions	Min	Тур	Max	Units
Static Parameter	,			1		
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> =250μA	40			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =40V,V <sub>GS</sub> =0V			1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	$V_{GS}$ = $\pm 20V$ , $V_{DS}$ = $0V$			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0	1.5	2.5	V
Chatia Dunius Courses On Benintana	Б	V <sub>GS</sub> = 10V, I <sub>D</sub> =20A		15	19	- mΩ
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> =10A		18	25	
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =20A,V <sub>GS</sub> =0V		0.7	1.2	V
Dynamic Parameters						
Input Capacitance	C <sub>iss</sub>			800		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> =20V,V <sub>GS</sub> =0V,f=1MHZ		112		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			94		
Switching Parameters						
Total Gate Charge	Qg			23.6		
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> =10V,V <sub>DS</sub> =20V,I <sub>D</sub> =20A		4.4		·- C
Gate-Drain Charge	$Q_{gd}$			6.3		- nC
Reverse Recovery Charge	Q <sub>rr</sub>	1.004 1/1/1 4004/		0.4		
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> =20A, di/dt=100A/us		7		
Turn-on Delay Time	t <sub>D(on)</sub>			10		
Turn-on Rise Time	t <sub>r</sub>	V 40//V 00// 04 5 65		56		ns
Turn-off Delay Time	t <sub>D(off)</sub>	$V_{GS}$ =10V, $V_{DD}$ =20V, $I_D$ =2A, $R_{GEN}$ =3 $\Omega$		27		
Turn-off fall Time	t <sub>f</sub>			72		

A. Pulse Test: Pulse Width  $\leq$  300us, Duty cycle  $\leq$  2%.

B.  $R_{\text{BJA}}$  is the sum of the junction-to-case and case-to-ambient thermal resistance, where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\text{BJC}}$  is guaranteed by design, while  $R_{\text{BJA}}$  is determined by the board design. The maximum rating presented here is based on mounting on a 1 in 2 pad of 2oz copper.



# **Typical Performance Characteristics**

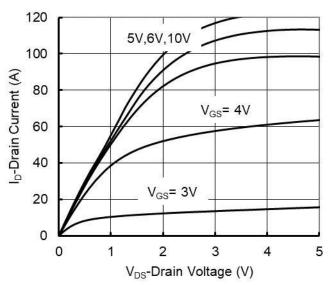


Figure 1. Output Characteristics

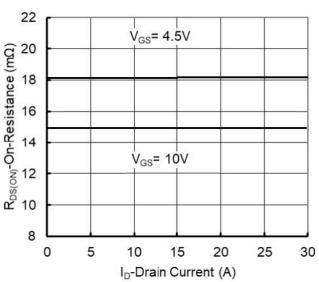


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

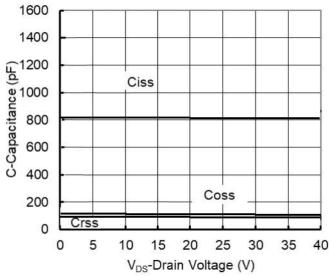


Figure 5. Capacitance Characteristics

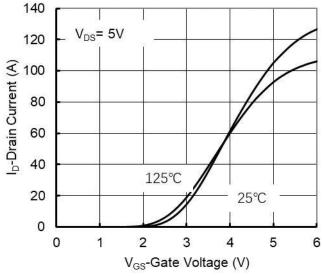


Figure 2. Transfer Characteristics

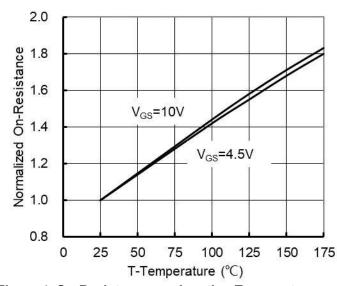


Figure 4. On-Resistance vs. Junction Temperature

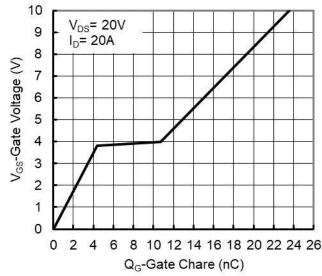


Figure 6. Gate Charge



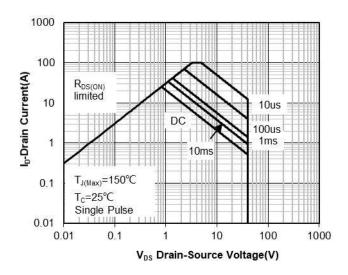


Figure 7. Safe Operation Area

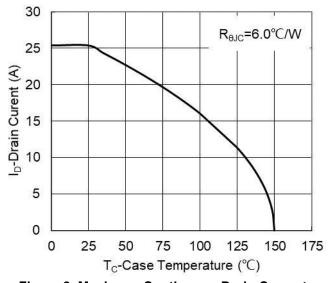


Figure 8. Maximum Continuous Drain Current vs Case Temperature

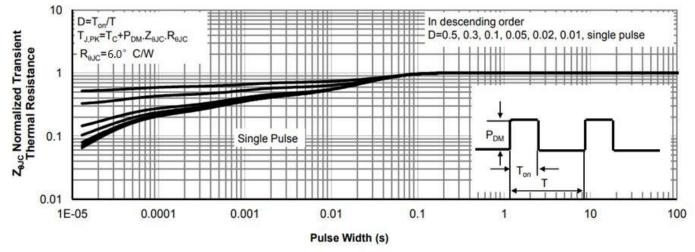
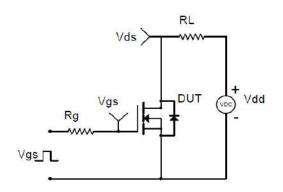
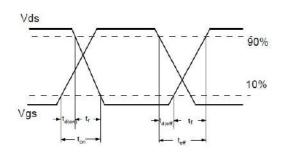


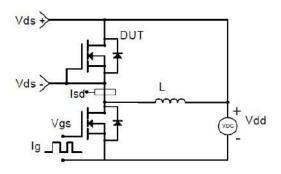
Figure 9. Normalized Maximum Transient Thermal Impedance

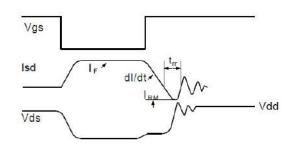




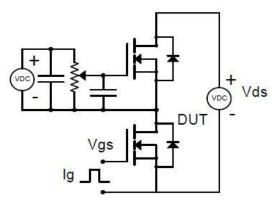


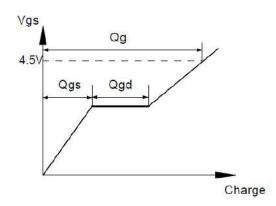
### **Resistive Switching Test Circuit & Waveforms**



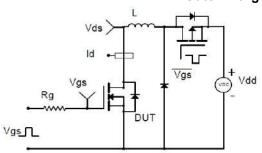


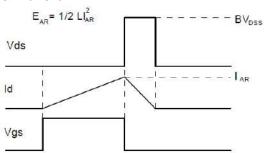
# **Diode Recovery Test Circuit & Waveforms**





# **Gate Charge Test Circuit & Waveform**





**Unclamped Inductive Switching (UIS) Test Circuit & Waveforms** 



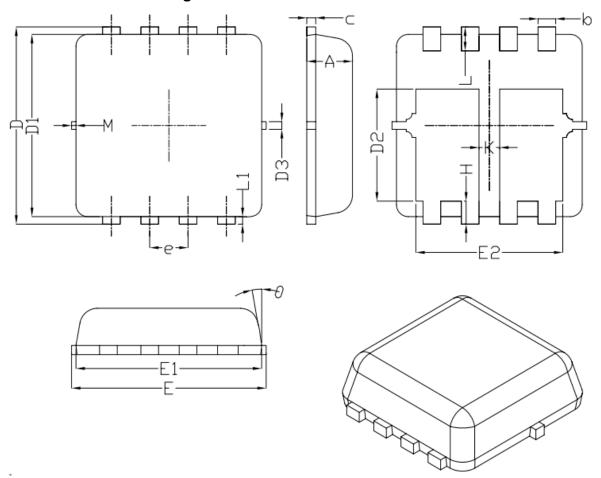
# **Ordering and Marking Information**

Ordering Device No.	Marking	Package	Packing	Quantity
ASDM40DN20E-R	40DN20	PDFN3.3*3.3-8	Tape&Reel	5000/Reel

PACKAGE	MARKING
PDFN3.3*3.3-8	AS



# **Dual PDFN3.3\*3.3-8 Package Outline Data**



-				
Symbol	Dimensions (unit: mm)			
	Min	Тур	Max	
Α	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.78	1.88	1.98	
D3		0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65 BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1		0.13		
K	0.30			
θ		10°	12°	
М	*	*	0.15	
* Not Specified				

#### Notes:

- 1. Refer to JEDEC MO-240 variation CA.
- 2. Dimensions "D1" and "E1" do NOT include mold flash protrusions or gate burrs.
- 3. Dimensions "D1" and "E1" include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25mm per side.



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# ASDM40DN20E

#### 40V Dual N-Channel Power MOSFET

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